

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
SHIN CHIN ET AL.

Examiner

DAVID B. LUGO

Art Unit

2611

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,391,715	06-2008	Lee et al.	370/208
*	B	US-2004/0071118	04-2004	Dabak et al.	370/335
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
	T					

NON-PATENT DOCUMENTS

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